

DESCRIPTION

2SC2134 is a silicon NPN epitaxial planar type transistor designed for RF power amplifiers in VHF band 24 to 28 volts operation applications.

FEATURES

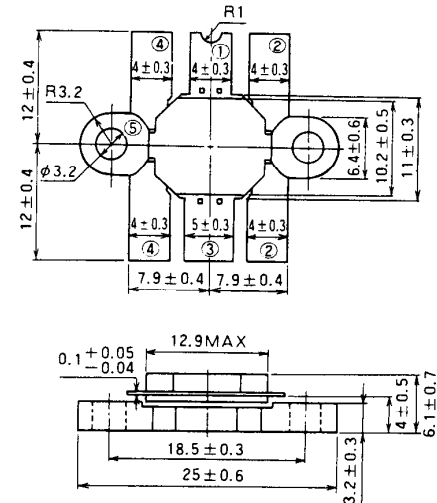
- High power gain: $G_{pe} \geq 7\text{dB}$
@ $V_{CC} = 28\text{V}$, $P_O = 60\text{W}$, $f = 220\text{MHz}$
- Emitter ballasted construction and gold metallization for high reliability and good performances.
- Low thermal resistance ceramic package with flange.
- Ability of withstanding more than 20:1 load VSWR when operated at $V_{CC} = 28\text{V}$, $P_O = 50\text{W}$, $f = 220\text{MHz}$, $T_C = 25^\circ\text{C}$.
- Equivalent input series impedance: $Z_{in} = 1 + j3\Omega$
@ $V_{CC} = 28\text{V}$, $P_O = 60\text{W}$, $f = 220\text{MHz}$

APPLICATION

20 to 30 watts output linear power amplifiers such as TV transposer amplifiers in VHF band.

OUTLINE DRAWING

Dimensions in mm



- PIN :
- ① COLLECTOR
 - ② EMITTER (FLANGE)
 - ③ BASE
 - ④ EMITTER (FLANGE)
 - ⑤ FIN (EMITTER)

T-40E

ABSOLUTE MAXIMUM RATINGS ($T_C = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Conditions	Ratings	Unit
V_{CBO}	Collector to base voltage		55	V
V_{EBO}	Emitter to base voltage		4	V
V_{CEO}	Collector to emitter voltage	$R_{BE} = \infty$	35	V
I_C	Collector current		10	A
P_C	Collector dissipation	$T_a = 25^\circ\text{C}$	4	W
		$T_C = 25^\circ\text{C}$	120	W
T_j	Junction temperature		175	$^\circ\text{C}$
T_{stg}	Storage temperature		-55 to 175	$^\circ\text{C}$
R_{th-a}	Thermal resistance	Junction to ambient	37.5	$^\circ\text{C}/\text{W}$
R_{th-c}		Junction to case	1.25	$^\circ\text{C}/\text{W}$

Note. Above parameters are guaranteed independently.

ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise specified)

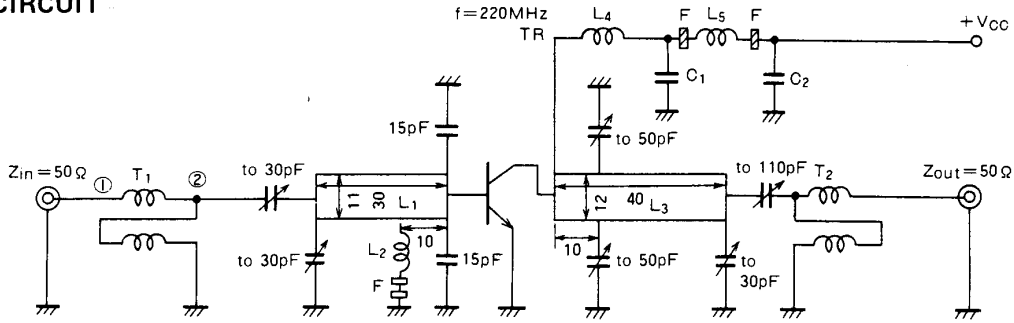
Symbol	Parameter	Test conditions	Limits			Unit
			Min	Typ	Max	
$V_{(BR)EBO}$	Emitter to base breakdown voltage	$I_E = 10\text{mA}$, $I_C = 0$	4			V
$V_{(BR)CBO}$	Collector to base breakdown voltage	$I_C = 50\text{mA}$, $I_E = 0$	55			V
$V_{(BR)CEO}$	Collector to emitter breakdown voltage	$I_C = 0.1\text{A}$, $R_{BE} = \infty$	35			V
I_{CBO}	Collector cutoff current	$V_{CB} = 35\text{V}$, $I_E = 0$			5	mA
I_{EBO}	Emitter cutoff current	$V_{EB} = 3\text{V}$, $I_C = 0$			2	mA
h_{FE}	DC forward current gain*	$V_{CE} = 25\text{V}$, $I_C = 0.2\text{A}$	20	50	110	—
P_O	Output power	$V_{CC} = 28\text{V}$, $P_{in} = 12\text{W}$, $f = 220\text{MHz}$	60	70		W
η_C	Collector efficiency		55	60		%

Note. * Pulse test, $P_W = 150\mu\text{s}$, $\text{duty} = 5\%$.

Above parameters, ratings, limits and conditions are subject to change.

NPN EPITAXIAL PLANAR TYPE

TEST CIRCUIT

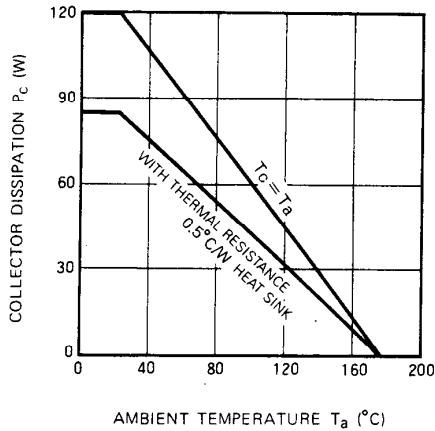


- L_1, L_3 : $t = 0.2\text{mm}$ copper plate
 L_2 : 10D, 7T, 2P, $\phi 1.0$ silver plated copper wire
 L_4 : 12D, 3T, 3P, $\phi 1.6$ silver plated copper wire
 L_5 : 10D, 15T, $\phi 1.0$ enameled wire
 T_1 : 4:1 transformer
 T_2 : 1:4 transformer
F: Ferrite Bead
 C_1 : 330pF, 1000pF, 4700pF, 0.01 μ F, 0.1 μ F, 4.7 μ F in parallel
 C_2 : 330pF, 1000pF, 4700pF, 0.01 μ F, 0.1 μ F, 4.7 μ F in parallel

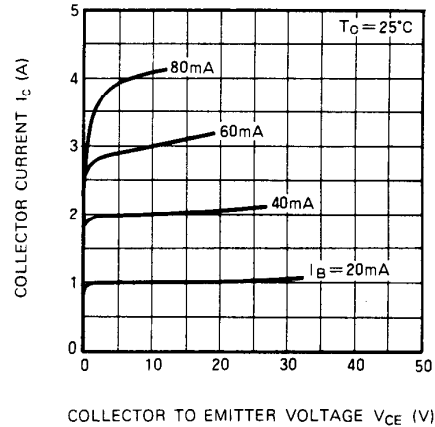
Notes: Coil
D: Inner diameter
P: Pitch
T: Turn number
Dimension in milli-meter

TYPICAL PERFORMANCE DATA

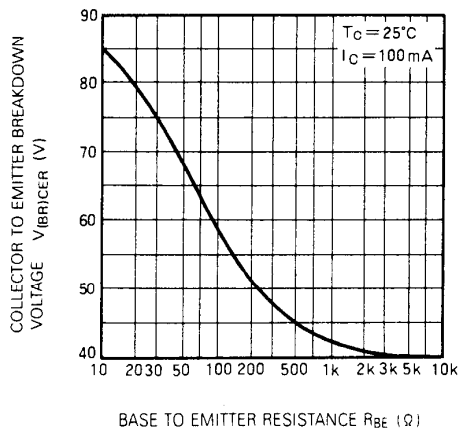
COLLECTOR DISSIPATION VS. AMBIENT TEMPERATURE



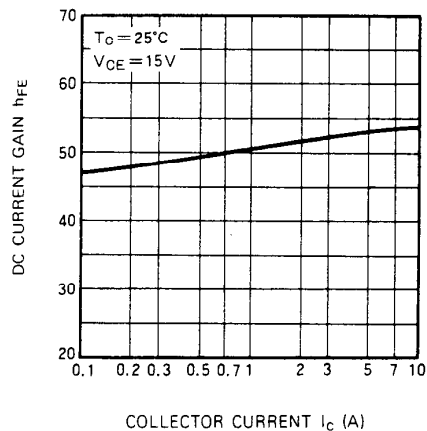
COLLECTOR CURRENT VS. COLLECTOR TO EMITTER VOLTAGE



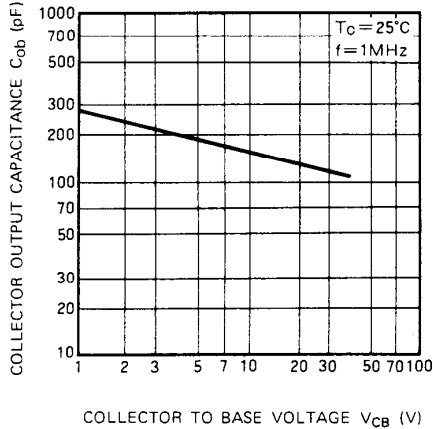
COLLECTOR TO EMITTER BREAKDOWN VOLTAGE VS. BASE TO EMITTER RESISTANCE



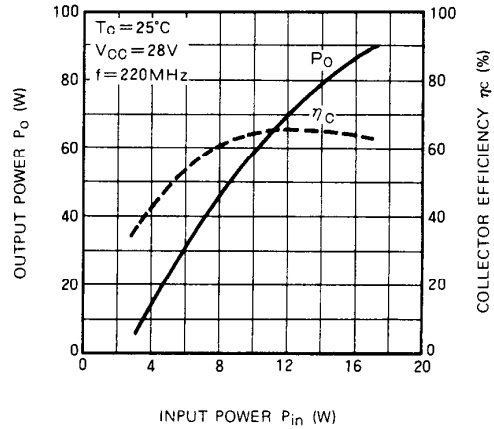
DC CURRENT GAIN VS. COLLECTOR CURRENT



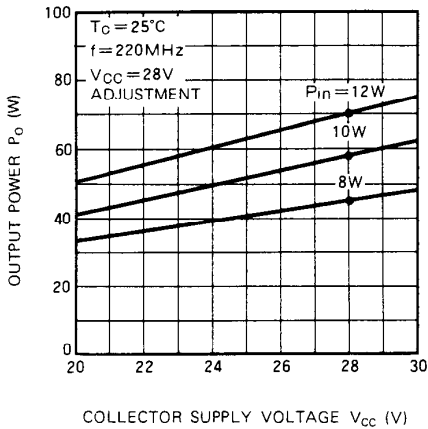
COLLECTOR OUTPUT CAPACITANCE VS. COLLECTOR TO BASE VOLTAGE



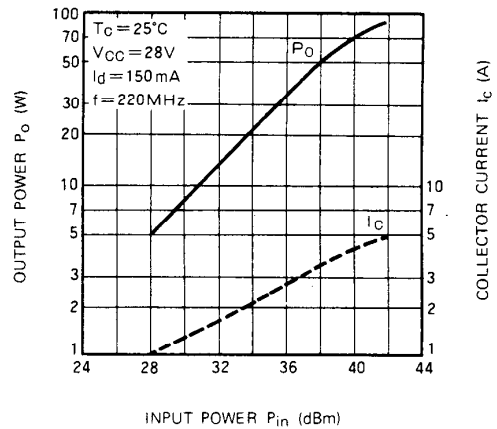
OUTPUT POWER, COLLECTOR EFFICIENCY VS. INPUT POWER



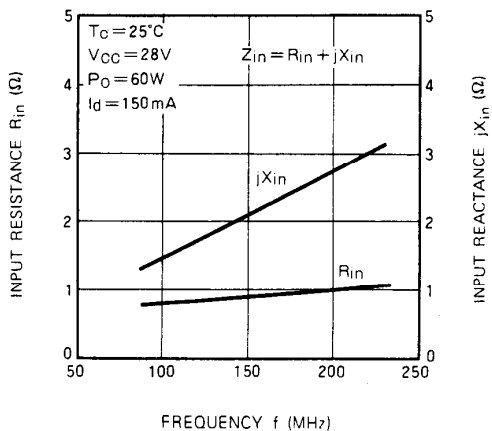
OUTPUT POWER VS. COLLECTOR SUPPLY VOLTAGE



IN CASE AB OPERATING OUTPUT POWER, COLLECTOR CURRENT VS. INPUT POWER



INPUT IMPEDANCE VS. FREQUENCY



OUTPUT IMPEDANCE VS. FREQUENCY

